

<b>Notic of References Cited</b>	Application/Control No. 10/077,924	Applicant(s)/Patent Under Reexamination.. NOHARA ET AL.	
	Examiner Hai H. Huynh	Art Unit 3747	Page 1 of 2

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	Examiner Hai H. Huynh	Art Unit 3747	Page 2 of 2

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